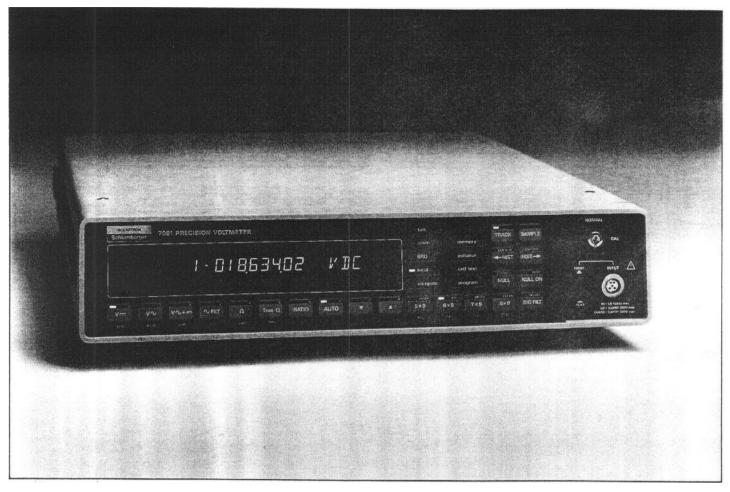
HIGH PERFORMANCE DMMS 7081 & 7071



■ Resolution 1 in 140 million

■ Cut the cost of ownership

DC Voltage 10nV to 1kV

Resolving one point in 140 million and 14 million respectively, the 7081 and 7071 use pulse-width conversion for unparalleled accuracy and linearity.

AC Voltage 1µV to 750V

True rms ac measurement from dc to 1MHz. A patented technique is used to remove the need for matching log-antilog transistors, improve long term stability and provide excellent ac performance from 1.5Hz to 1MHz with $1\mu V$ sensitivity. This conversion technique is faster than thermal rms convertors, more accurate over a wide dynamic range and can also measure ac + dc.

Resistance $10\mu\Omega$ to $>1400M\Omega$

4-terminal fully floating measurement to $1000k\Omega$. Two additional 2-wire conductance ranges extend measurement to greater than $1400M\Omega$.

Using Solartron's "True Ohm" function, thermal emf is eliminated by automatically measuring the voltage without excitation current and subtracting this from the normal resistance measurement.

■ The lowest-cost transportable standards room

Temperature

The 7081 and 7071 are the ultimate temperature standards with unmatched precision resistance measurement. Using a PRT (RTD), better than one millidegree resolution is provided with comparable accuracy. With one milliamp measuring current, dissipation is only 100μ W. These features mean you get performance exceeding that of resistance bridges. "True ohms" mode further improves the accuracy by eliminating thermal emf errors.

Current

For the best ac and dc current measurement the shunt resistor used must be suited to the level being measured. Use the 7081 or 7071 to measure the resistor of your choice and insert it in the circuit. You can then use the ratio program to divide the measured voltage by resistance for a result in mA. Low voltage burden and high sensitivity ensure accurate high current measurement. A very low leakage input amplifier enables superb low current measurement accuracy.

■ No need for frequent re-calibration

Ratio

Eight different ratio measurements are available. Ratio to an reference input of up to ±14V dc or to a numerical constant. The latter may be a measurement result accessed from the voltmeter memory. The ratios are presented as linear or logarithmic (dB).

Digital Calibration

Calibration via the IEEE488 or RS232 interface. See the description on page A3.

History file

Memory can retain and recall the most recent 500 results in full format (including time and date) or 1500 in a compressed (numeric value only) format. The file can be recalled and displayed either from the front panel or via the systems interface.

Filter

Pulse-width conversion combined with digital filtering provides excellent noise rejection without the need for analog filters. Problems associated with analog filters include long settling time and dielectric absorbtion which causes new measurements to be biased by old ones. Three digital filter types are offered:

Continuous average: the average of all measurements, updated by each new measurement.

Simple average: the average of a user specified number of measurements.

Walking window average: specify a sample window size N. The result is always the average of the last N measurements.

Processing

The 7081 contains powerful software enabling built-in programs to convert raw measurements into more useful results. Programs include:

- Average
- Variance
- Standard Deviation
- Root Mean Square
- Scaling
- Peak to Peak
- Limits
- Linear Ratio
- Log Ratio (dB)
- Offset

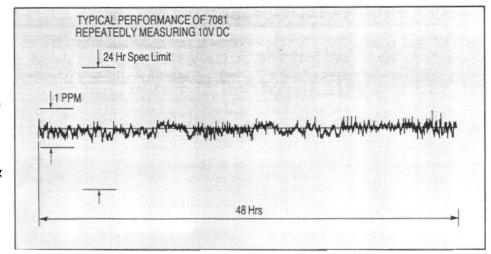
A feature of the processing program is that while one result is being output, others are retained for subsequent recall. Furthermore, the programs may be strung together so that the result from one enters the next. Hence a ratio measurement, for example, could be averaged, scaled and compared with limits.

Time control

A real-time clock and calendar with a 10-year battery provides real and elapsed time control of measurements. Just specify begin time, interval and end time to accomplish automatic measurements by day or night, or over weekends. The results will be stored in the 1500 reading history file or output directly to a controller or a printer.

Systems Interface

The IEEE488 and RS232 interfaces are included as standard with full Talk/Listen and Talk Only operation. Commands are in easily understood ENGLISH format but may be abbreviated to reduce message size. Communication with all popular controllers is fast to set up and easy to implement.



ROOT YEAR RELATIONSHIP

Realistic specifications should not be based on speculation. They require a real knowledge of components, their behaviour under stress, and their drift with time.

Long-term assessment of precision components has enabled Solartron to specify performance from 90 days to 9 years using a simple square-root-year relationship for calibration drift with time. Tests conducted over several years using precision resistors and zeners from many leading manufacturers indicate that drift reduces with time and the change is porportional to the square root of time. Using pre-aged, hermetically encapsulated components, the drift is reduced to extremely low levels, and can be predicted accurately for short or long periods. Accuracy specified for one year can be used with a multiplier to provide all additional information as shown below:

Required Spec Time	One year Multiplier
3 month	0.5
6 month	0.7
l year	1.0
2 year	1.4
4 year	2.0
9 vear	3.0

CALIBRATED FOR LIFE

Beyond 9 years the drift becomes insignificant such that 3 times the one year figure will predict the performance for the life of the voltmeter - however long that may be. Traceability to International Standards can be maintained for long periods.

The square-root-year relationship applies to both 7071 and 7081. Both will retain their predicted long term specification even if subjected to rigorous working conditions. However, the best stability and minimum long term drift will be obtained by maintaining the instrument in a reasonable environment. The user should consider leaving these precision voltmeters switched on and avoid extreme environmental conditions. In these circumstances the long term performance can be expected to be even better than that which is predicted.

Calibration for Life, now introduced for the first time by Solartron, gives important savings in time and money, thus making a significant reduction in cost of ownership.

ACCURACY

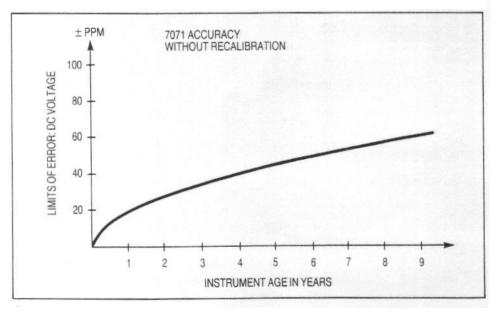
The following apply to the Accuracy sections: Limits of Error: apply after 24 hours warm-up* ac inputs >2% of range dc and resistance with null in use

* Instruments are usable within minutes after switch-on but for ultimate precision a long warm-up is recommended in a stable thermal environment.

Temperature coefficient: expressed as ±ppm rdg/°C valid from 10 to 30°C

Temperature coefficient need be applied only outside the temperature span quoted with Te.

Calibration Temperature (T_c) is the temperature of the calibration room environment. Calibration occurs at 20°C (23°C for USA) and is directly traceable to International Standards via the National Physical Laboratory or the National Bureau of Standards. Recalibration is valid at Te from 18°C to 25°C.



7071 DC VOLTAGE Scale length 14 000 000 Predicted limits of error for life: 60ppm rdg + 1ppm fs

STABILITY 24hrs, 71/2 digits \pm [ppm rdg + ppm fs] T_{*} \pm 1°C

Range	Sensitivity	Guaranteed	Transfer
0.1V	10nV		
1V	100nV		
10V	اس√ ⊢	3.0 + 1.0	0 + 1.0
100V	10µV		
1000V	100μV 🔟		

Input Resistance: 0.1, 1, 10V range: 100, 1000V range:

Input Current, at T. °C:

 $>10G\Omega$ $10M\Omega \pm 0.1\%$

<20pA

LIMITS OF ERROR per square-root-year \pm [ppm rdg + ppm fs] T_e \pm 5°C

Range	Guaranteed	Typical	Temp. Coeff
0.1V	7		
IV			
10V	-20+1	14 + 0.8	2.0
100V			
1000V			

Range of Null:

±10% of range Sample settling time: 13ms × (digits selected)

INTEGRATION TIME, TRACKING SPEED

Digits	Integration	Speed	Add Error
71/2	3.2s	1/3.2s	
61/2	0.4s	2.5/s	±1 digit
51/2	0.1s	10/s	±1 digit
4 ¹ / ₂	6.25ms	85/s	±1 digit
31/2	1.56ms	100/s	±1 digit

Overload Protection

Autorange:

Commanded range: 0.1, 1, 10V: 100, 1000V:

lkV pk 350V pk IkV pk

lkV pk

7071 AC VOLTAGE True rms of ac or ac+dc Scale length 1 400 000

STABILITY

24hrs, T_e ± 1°C, ± [% reading + % full scale]

Range	Sensitivity	10 to 40Hz	40Hz to 10kHz	10k to 100kH
0.1V	$1\mu V$	0.05 ± 0.006	0.005 + 0.005	0.02 + 0.03
1V	lμV	0.05 ± 0.006	0.005 ± 0.005	0.02 ± 0.03
10V	10μV	0.05 ± 0.006	0.015 ± 0.005	0.05 ± 0.03
100V	$100 \mu V$	0.06 ± 0.006	0.02 + 0.005	0.2 + 0.03
1000V	lmV	0.08 ± 0.01	0.035 + 0.007	

LIMITS OF ERROR

Error per square-root-year, T_e ± 5°C, ± [% reading + % full scale]

0.1V $0.06 + 0.005$ $0.02 + 0.005$ $0.04 + 0.04$ $1 + 1$	1MHz
1V = 0.06 + 0.005 = 0.02 + 0.005 = 0.04 + 0.04 = 1 + 1	
10V = 0.06 + 0.005 = 0.03 + 0.005 = 0.07 + 0.04 = 1 + 1	
100V = 0.07 + 0.005 = 0.04 + 0.005 = 0.22 + 0.04 = -	
1000V = 0.09 + 0.01 = 0.05 + 0.007 =	

INTEGRATION TIME, TRACKING SPEED

Digits	Display	Integ	Speed	Add Error
$7\frac{1}{2}$	61/2	3.2s	1/3.2	1982-193
$6\frac{1}{2}$	$5\frac{1}{2}$	0.4s	2.5/s	
$5\frac{1}{2}$	4 1/2	0.1s	10/s	±1 digit
41/2	31/2	6.25ms	85/s	±1 digit
$3\frac{1}{2}$	31/2	1.56ms	100/s	±2 digits

Low Frequency Error below lkHz

5 to 10Hz 3 to 5Hz 2 to 3Hz 1.5 to 2Hz DC Input Impedance: Temp, Coeff, up to 10kHz:

use ~ Filt. add 0.25% rdg add 0.3% rdg Maximum Inputs add 0.6% rdg

add 1.0% rdg add 0.1% rdg 1MΩ||150 pF ±30 ppm rdg/°C Sample settling time: - Filter selected:

20ms × (digits selected) 400ms \times (digits selected)

Maximum V × Hz:

Crest Factor at fs:

Autorange: 0.1, IV: Commanded range:

350V pk 10, 100, 1000V: 1kV pk 107 5:1

7071 RESISTANCE Scale length 14 000 000 Predicted limits of error for life: 3 × guaranteed limits

STABILITY 24hrs, 71/2 digits \pm [ppm rdg + ppm fs| T_e \pm 1°C

Range	Sensitivity	Guaranteed	Transfe
$0.1k\Omega$	10μΩ	3 + 1	0 + 1
$lk\Omega$	$100\mu\Omega$	3 + 1	0 + 1
$10 \mathbf{k} \Omega$	$lm\Omega$	3 + 1	0 + 1
$100 \mathrm{k}\Omega$	$10 \text{m}\Omega$	3 + 1	0 + 1
$1000 { m k}\Omega$	$100 \mathrm{m}\Omega$	4+1	0 + 1
$10 \mathrm{M}\Omega$	1Ω	10 + 1	0 + 1
1000MO	Donn rdg	Innm/MO	

4-wire, $0.1 k\Omega$ to $1000 k\Omega$ ranges – Maximum total lead resistance: Measurement:

Current source:

2-wire, $10M\Omega$ and $1000M\Omega$ range. Sample settling time: $0.1.1 \pm 10$ k Ω ImA $100k\Omega$, $1000k\Omega$ 10μ A $10M\Omega$, $1000M\Omega$ -1μ A max

LIMITS OF ERROR per square-root-year \pm [ppm rdg + ppm fs| T_e \pm 5°C

Range	Guaranteed	Temp. Coeff
0.1 k Ω	20 + 1	2
lkΩ	20 + 1	2
10 k Ω	20 + 1	2
100kΩ	20 + 1	2
1000 k Ω	20 + 1	2
$10M\Omega$	60 ± 1	5
$1000 \mathrm{M}\Omega$	10 ppm/ ${ m M}\Omega$	$lppm/M\Omega$

13ms × (digits selected)

INTEGRATION TIME, TRACKING SPEED

Integration	Speed	Add Error
3.2s	1/3.2s	
0.4s	2.5/s	± l digit
0.1s	10/s	±1 digit
6.25ms	85/s	±1 digit
1.56ms	100/s	±1 digit
	3.2s 0.4s 0.1s 6.25ms	3.2s 1/3.2s 0.4s 2.5/s 0.1s 10/s 6.25ms 85/s

Add 10ms/MΩ Range of Null:

Overload protection: Open circuit voltage:

350V pk 17V de ±10% of range

7081 AND 7071

GENERAL

Power Supply

110/120/220/240V + 15% - 10%Voltage: Frequency, automatic sensing: 48 to 52Hz, 57 to 63Hz, 384 to 416Hz

Consumption:

Environment

40 V.A

0°C to +45°C Operating: $-20^{\circ}\text{C to} + 70^{\circ}\text{C}$ Storage: Relative Humidity: 90% at 40°C (non condensing)

Dimensions

Height: 88mm (3.5ins) Width: 432mm (17ins) Depth: 419mm (16.5ins) Weight: 8.25kg (19lbs)

Designed in accordance with IEC 348, BS4743 and UT,1244

7081 DC VOLTAGE Scale length 140 000 000

STABILITY 24hrs, 8½ digits ± [ppm rdg + ppm fs] T _e ± 1°C				
Range	Sensitivity	Guaranteed	Transfer	
0.1V	$10 \mathrm{nV}$	2.0 ± 0.8	0 + 0.8	
11	$10 \mathrm{nV}$	2.0 ± 0.4	0 + 0.4	
10V	$100 \mathrm{nV}$	1.2 ± 0.3	0 + 0.3	
100V	$1\mu V$	2.0 ± 0.4	0 + 0.4	
1000V	$10\mu V$	3.0 ± 0.3	0 ± 0.3	

Input Resistance: 0.1, 1, 10V range: >10GΩ 100, 1000V range: $10 \mathrm{M}\Omega \pm 0.1\%$

LIMITS OF ERROR per square-root-year \pm [ppm rdg + ppm fs] T_e \pm 5°C

Range	Guaranteed	Typical	Temp. Coeff
0.1V	13 ± 0.8	8 ± 0.6	1.5
IV	13 ± 0.4	8 ± 0.4	1.3
10V	11 ± 0.3	7 ± 0.3	0.8
100V	14 ± 0.4	8 ± 0.4	1.6
1000V	13 + 0.3	8 + 0.3	1.5

Input Current, at Te °C: Range of Null: Sample settling time:

<20pA ±10% of range 13ms × (digits selected)

INTEGRATION TIME, TRACKING SPEED Digits Integration Speed Add Error $8\frac{1}{2}$ 51.2s1/51.2s 714 1.3.2s3 25 ±2 digits 2.5/8 $6\frac{1}{2}$ ±1 digit 0.4s $5^{1}-2$ 0.1s10/8 ±1 digit 41/2 6.25 ms85-s ±1 digit 1.56ms 100% ±1 digit

Overload Protection

Autorange: 1kV pk $350 \mathrm{V} \; \mathrm{pk}$ Commanded range: 0 1 1 10V 100, 1000V: 1kV pk

7081 AC VOLTAGE True rms of ac or ac+dc Scale length 1 400 000

24hrs, Te ± 1°C, ± [% reading + % full scale]

Range	Sensitivity	10 to 40Hz	40Hz to 10kHz	10k to 100kHz
0.1V	$1 \mu V$	0.05 ± 0.006	0.005 + 0.005	0.02 ± 0.03
1 V	1μ\'	0.05 ± 0.006	0.005 ± 0.005	0.02 ± 0.03
10V	$10 \mu V$	0.05 ± 0.006	0.012 ± 0.005	0.05 ± 0.03
100V	100μ.\`	0.06 ± 0.006	0.017 ± 0.005	0.20 ± 0.03
1000V	$1 \mathrm{mV}$	0.08 ± 0.01	0.035 ± 0.007	

LIMITS OF ERROR Error per square-root-year, T_e ± 5°C, ± [% reading + % full scale] Range 10 to 40Hz

0.1V

1V

10V

100V

10001

40Hz to 10kHz 10k to 100kHz 100k to 1MHz 0.03 ± 0.04 0.06 ± 0.006 0.015 ± 0.005 1 + 11 + 10.06 + 0.006 0.015 ± 0.005 0.03 ± 0.04 0.06 ± 0.04 0.06 + 0.006 0.022 ± 0.005 1 + 10.07 + 0.006 0.027 ± 0.005 0.21 ± 0.04 0.09 + 0.01 0.045 ± 0.007

INTEGRATION TIME, TRACKING SPEED Digits Display Integ Add Error Speed 8×9 51.2s 1/51.2 7×9 $6\frac{1}{2}$ 3.2s1/3.26×9 $51/_{2}$ 0.4s2.5/5 5×9 41/ 0.1s10/s±1 digit 31/2 4×9 6.25ms 85/s ±1 digit 1.56ms 100/s ± 2 digits

Low Frequency Error below lkHz use ~ Filt. add 0.25% rdg 5 to 10Hz 3 to 5H2 add 0.3% rdg 2 to 3Hz add 0.6% rdg 1.5 to 2Hz add 1.0% rdg DC add 0.1% rdg Input Impedance: 1MΩ||150 pF Temp, Coeff, up to 10kH2: ±30 ppm rdg/°C

20ms × (digits selected) Sample settling time: ~ Filter selected: 400ms × (digits selected) **Maximum Inputs**

Autorange: 1kV pk 0.1, 1V:350V pk Commanded range: 10, 100, 1000V: 1kV pk Maximum V × Hz: 107 Crest Factor at fs: 5:1

7081 RESISTANCE Scale length 140 000 000

STABILITY 24hrs, 81/2 digits ± [ppm rdg + ppm fs] T_e ± 1°C

Range	Sensitivity	Guaranteed	Transfer
$0.1k\Omega$	10μΩ	2.0 ± 0.8	0 + 0.8
$1k\Omega$	$10\mu\Omega$	2.0 ± 0.4	0 + 0.4
10 k Ω	$100\mu\Omega$	1.5 ± 0.3	0 + 0.3
$100k\Omega$	$1 \mathrm{m} \Omega$	2.0 ± 0.4	0 + 0.4
$1000 \mathrm{k}\Omega$	$10 \text{m}\Omega$	3.0 + 0.3	0 + 0.3
$10 \mathrm{M}\Omega$	$100 m\Omega$	10 + 0.5	0 + 0.5
$1000 M\Omega$	1ppm rdg	$1 \mathrm{ppm/M}\Omega$	

4-wire, $0.1 \text{k}\Omega$ to $1000 \text{k}\Omega$ ranges Measurement: 2-wire, $10 \mathrm{M}\Omega$ and $1000 \mathrm{M}\Omega$ range

 $0.1, 1, 10k\Omega$ Current source: $10\mu A$

 $100k\Omega$, $1000k\Omega$ 10MΩ, 1000MΩ -1μA max LIMITS OF ERROR per square-root-year \pm [ppm rdg + ppm fs] T_e \pm 5°C

Range	Guaranteed	Temp. Coeff
$0.1k\Omega$	16 + 1.0	1.5
lkΩ	16 ± 0.5	1.5
10 k Ω	14 + 0.5	1.2
$100 \mathrm{k}\Omega$	16 ± 0.5	1.5
$1000 \mathrm{k}\Omega$	14 ± 0.5	1.2
$10 \mathrm{M}\Omega$	45 ± 0.5	5.0
$1000 M\Omega$	$10 \mathrm{ppm/M}\Omega$	1 ppm/ $M\Omega$

Maximum total lead resistance: 1kO

Sample settling time: 13ms × (digits selected) $Add\ 10ms/M\Omega$ **INTEGRATION TIME, TRACKING SPEED**

Digits Integration Speed Add Error 81/2 51.2s 1/51.2s71/2 3.2s1/3.2s±2 digits 61/2 (145 2.5/s±1 digit 51/2 0.1s10/s±1 digit 41/2 6.25 ms85/s ±1 digit 31/2 1.56ms 100/s ±1 digit

Overload protection: 350V pk Open circuit voltage: 17V dc ±10% of range Range of Null:

7081 AND 7071

INTERFERENCE REJECTION

Normal Mode Rejection, dc measurement $8\frac{1}{2}$ to $5\frac{1}{2}$ digits, 50(60) or 400Hz, $\pm 3\% > 70$ dB **Effective Common Mode Rejection**

With 1kΩ imbalance. DC measurement

 $8\frac{1}{2}$ to $5\frac{1}{2}$ digits, at 50(60)Hz, $\pm 3\%$: >140dB $8\frac{1}{2}$ to $5\frac{1}{2}$ digits, at 400Hz $\pm 3\%$: >120dB

AC measurement

Rejection of 50/60Hz ± 3%: >40dB Maximum permitted common mode: 500V

*71/2 for 7071

SYSTEMS USE

The following interfaces are provided as standard. IEEE488 (1978)

Provides full talker/listener facilities and remote control of all functions.

Subset: SH1, AH1, T5, TE0, L3, LE0, E1, SR1, RL1, DC1, C0, DT1, PP1.

Provides full remote control of all functions Speed, user selectable: 110 to 9600 bits/s Scanner

Interface provided for Minate (7010)

Channels: Pull in and drop out delays: Additional control lines

External Sample: contact closure Sample complete: TTL level open collector 40mA Out of limit High: Out of limit Low: open collector 40mA

16 to 128

programmable